Applicant(s)/Patent Under Reexamination NASSIOPOULOU ET AL. 10/502,465 Notice of References Cited Art Unit Examiner Page 1 of 1 2884 Frederick F. Rosenberger

Application/Control No.

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,139,758	10-2000	Tu, Xiangzheng	216/2
*	В	US-6,803,637	10-2004	Benzel et al.	257/414
*	С	US-5,565,084	10-1996	Lee et al.	205/646
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ö					
	R					
	S					
	Т			_		·

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	Hedrich, F. et al. "Structuring of Membrane Sensors Using Sacrificial Porous Silicon." Sensors and Actuators A - Physical, Vol. 84 (2000), pp. 315-323.
	٧	Sabate, N. et al. "Evaluation of Sensitive Materials for Integrated Thermal Flow Sensors." Proceedings of the IEEE Annual Conference of the Industrial Electronics Society, Vol. 4 (2002), pp. 2681-2684.
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.